

Abstract Submitted  
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**First-order metal-insulator transition not accompanied by the structural phase transition observed in VO<sub>2</sub>-based devices** HYUN-TAK KIM, BYUNG-GYU CHAE, BONG-JUN KIM, YONG-WOOK LEE, SUN-JIN YUN, KWANG-YONG KANG, ETRI in Korea — An abrupt first-order metal-insulator transition (MIT) is observed during the application of a switching pulse voltage to VO<sub>2</sub>-based two-terminal devices. When the abrupt MIT occurs, the structural phase transition (SPT) is investigated by a micro-Raman spectroscopy and a micro-XRD. The result shows that the MIT is not accompanied with the structural phase transition (SPT); the abrupt MIT is prior to the SPT. Moreover, any switching pulse over a threshold voltage of 7.1 V for the MIT enabled the device material to transform efficiently from an insulator to a metal. The measured delay time from the source switching pulse to an induced MIT pulse is an order of 20 nsec which is much less than a delay time of about one msec deduced by thermal model. This indicates that the first-order MIT does not occur due to thermal. We think this MIT is the Mott transition. (Reference: New J. Phys. 6 (1994) 52 ([www.njp.org](http://www.njp.org)), Appl. Phys. Lett. 86 (2005) 242101, Physica B 369 (2005. December) xxxxx)

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